

SKiM429GD17E4HD



SKiM[®] 93

Trench IGBT Modules

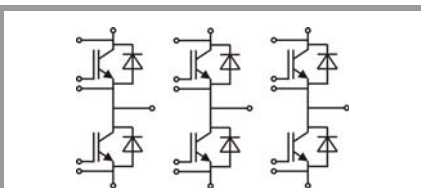
SKiM429GD17E4HD

Features

- IGBT 4 Trench Gate Technology
- Solderless sinter technology
- Low inductance case
- Isolated by AL₂O₃ DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts and electrical contacts
- High short circuit capability, self limiting to 6 x I_C
- Integrated temperature sensor

Typical Applications*

- Automotive inverter
- High reliability AC inverter wind
- High reliability AC inverter drives



GD

Absolute Maximum Ratings				
Symbol	Conditions	Values	Unit	
IGBT				
V _{CES}		1700	V	
I _C	T _j = 175 °C	T _s = 25 °C T _s = 70 °C	595 479	A A
I _{Cnom}		420	A	
I _{CRM}	I _{CRM} = 3xI _{Cnom}	1260	A	
V _{GES}		-20 ... 20	V	
t _{psc}	V _{CC} = 1200 V V _{GE} ≤ 15 V V _{CES} ≤ 1700 V	T _j = 150 °C	10	μs
T _j		-40 ... 175	°C	
Inverse diode				
I _F	T _j = 150 °C	T _s = 25 °C T _s = 70 °C	413 298	A A
I _{Fnom}		420	A	
I _{FRM}	I _{FRM} = 2xI _{Fnom}	840	A	
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C	3699	A	
T _j		-40 ... 150	°C	
Module				
I _{t(RMS)}	T _{terminal} = 80 °C	700	A	
T _{stg}		-40 ... 125	°C	
V _{isol}	AC sinus 50 Hz, t = 1 min	3300	V	

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
V _{CE(sat)}	I _C = 420 A V _{GE} = 15 V chiplevel	T _j = 25 °C T _j = 125 °C	1.90 2.1	2.25 2.3	V V
V _{CE0}		T _j = 25 °C T _j = 125 °C	1.1 1	1.2 1.1	V V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C T _j = 125 °C	1.9 2.6	2.5 2.9	mΩ mΩ
V _{GE(th)}	V _{GE} =V _{CE} , I _C = 16.8 mA	5.2	5.8	6.4	V
I _{CES}	V _{GE} = 0 V V _{CE} = 1700 V	T _j = 25 °C	0.15	0.45	mA mA
C _{ies}	V _{CE} = 25 V	f = 1 MHz	33.00		nF
C _{oes}	V _{GE} = 0 V	f = 1 MHz	1.38		nF
C _{res}		f = 1 MHz	1.08		nF
Q _G	V _{GE} = - 8 V...+ 15 V		6660		nC
R _{Gint}	T _j = 25 °C		2.7		Ω
t _{d(on)}	V _{CC} = 1200 V	T _j = 125 °C	390		ns
t _r	I _C = 420 A	T _j = 125 °C	80		ns
E _{on}	R _{G on} = 3.6 Ω	T _j = 125 °C	245		mJ
t _{d(off)}	R _{G off} = 3.6 Ω	T _j = 125 °C	1005		ns
t _f	di/dt _{on} = 5200 A/μs di/dt _{off} = 2200 A/μs	T _j = 125 °C	170		ns
E _{off}		T _j = 125 °C	180		mJ
R _{th(j-s)}	per IGBT		0.079		K/W

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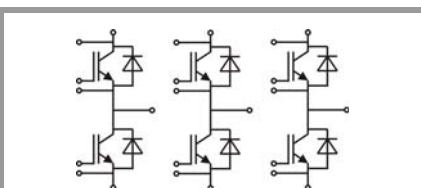
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
$V_F = V_{EC}$	$I_F = 420 \text{ A}$ $V_{GE} = 0 \text{ V}$ chip	$T_j = 25 \text{ }^\circ\text{C}$		1.7	1.9	V
		$T_j = 125 \text{ }^\circ\text{C}$		1.6	1.8	V
V_{F0}		$T_j = 25 \text{ }^\circ\text{C}$	0.9	1.1	1.3	V
		$T_j = 125 \text{ }^\circ\text{C}$	0.7	0.9	1.1	V
r_F		$T_j = 25 \text{ }^\circ\text{C}$	1.3	1.3	1.3	m Ω
		$T_j = 125 \text{ }^\circ\text{C}$	1.8	1.8	1.8	m Ω
I_{RRM}	$I_F = 420 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$		500		A
Q_{rr}	$di/dt_{off} = 5990 \text{ A}/\mu\text{s}$	$T_j = 125 \text{ }^\circ\text{C}$		140		μC
E_{rr}	$V_{GE} = -15 \text{ V}$ $V_{CC} = 1200 \text{ V}$	$T_j = 125 \text{ }^\circ\text{C}$		99		mJ
$R_{th(j-s)}$	per diode				0.169	K/W
Module						
L_{CE}				10	15	nH
$R_{CC'+EE'}$	terminal-chip	$T_s = 25 \text{ }^\circ\text{C}$		0.3		m Ω
		$T_s = 125 \text{ }^\circ\text{C}$		0.5		m Ω
w				1042		g
Temperature sensor						
R_{100}	$T_{Sensor} = 100 \text{ }^\circ\text{C}$ ($R_{25} = 5 \text{ k}\Omega$)			339		Ω
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T - 1/373)]$; $T[\text{K}]$;			4096		K

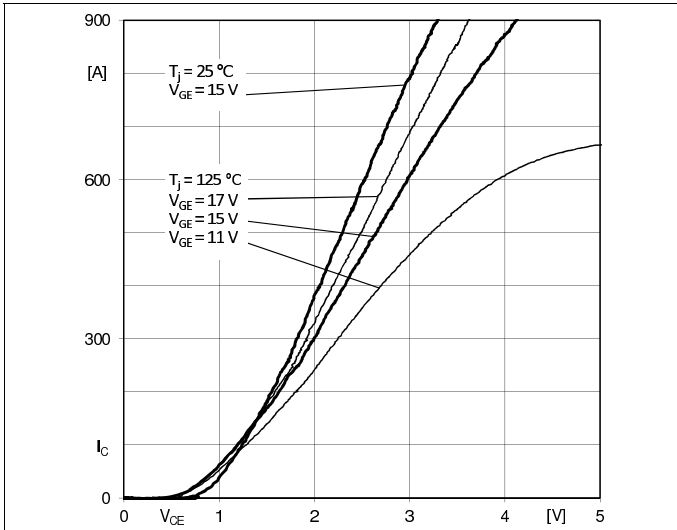


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+EE'}$

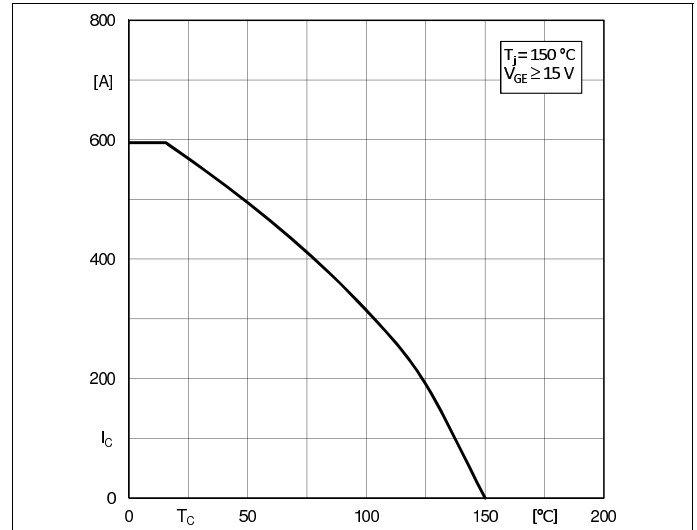


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

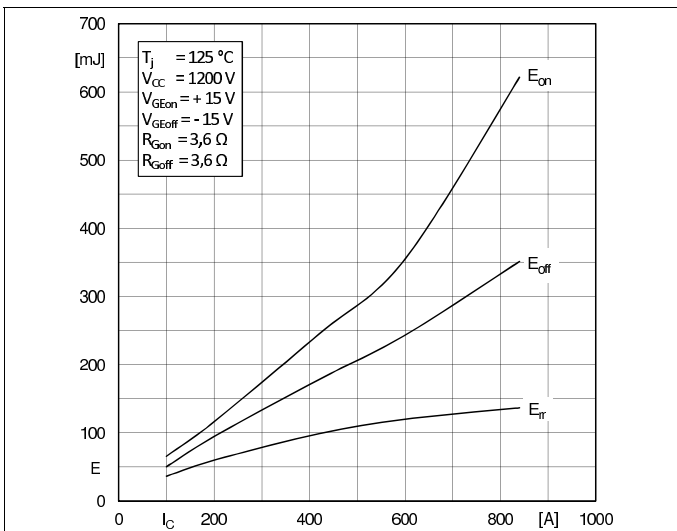


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

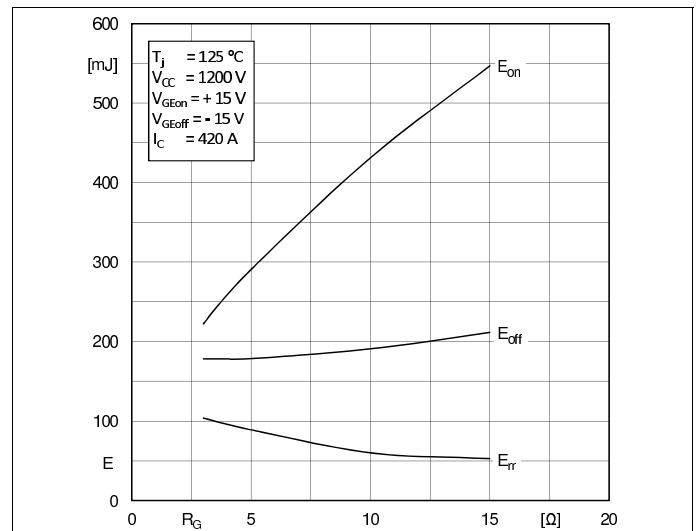


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

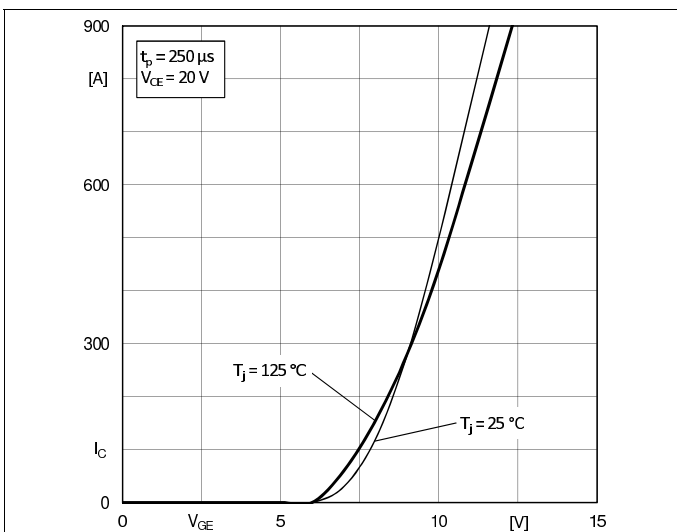


Fig. 5: Typ. transfer characteristic

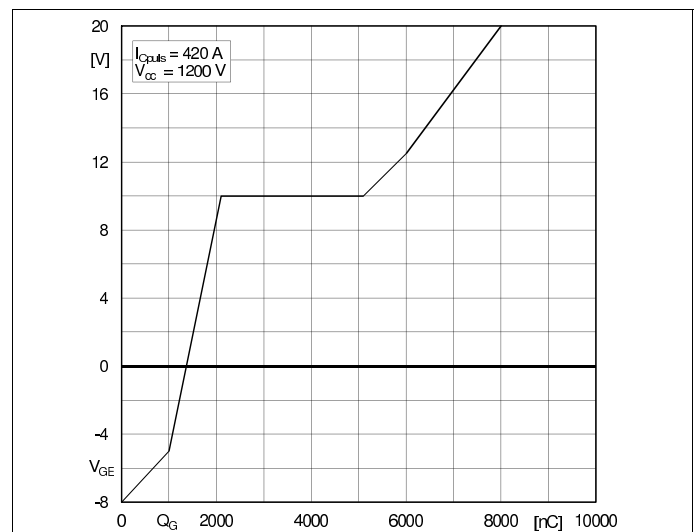


Fig. 6: Typ. gate charge characteristic

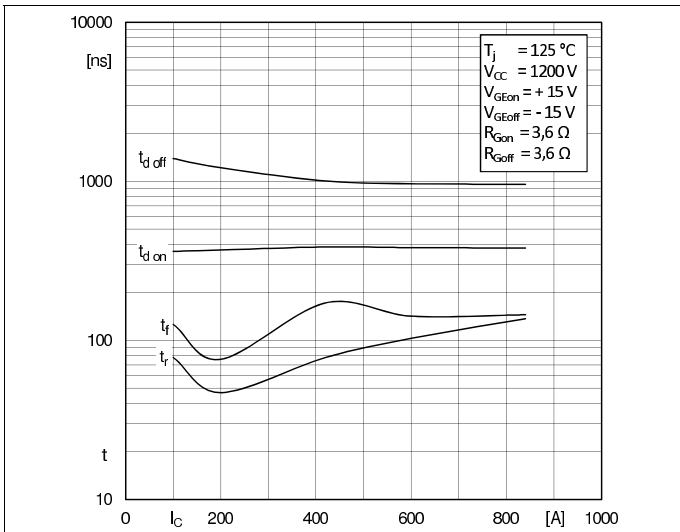


Fig. 7: Typ. switching times vs. I_C

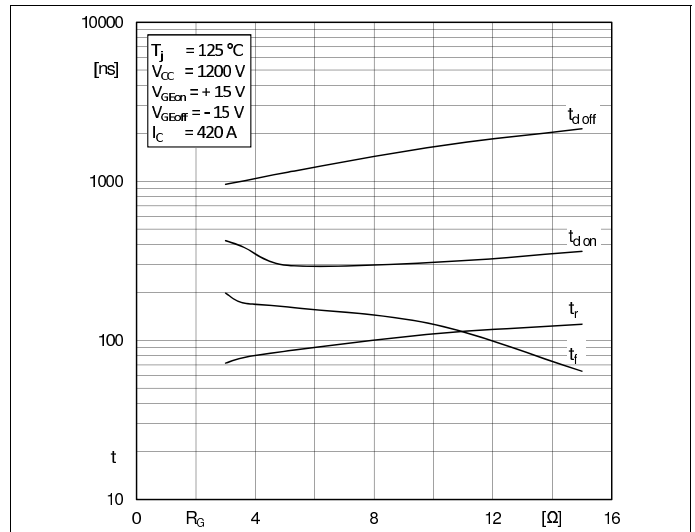


Fig. 8: Typ. switching times vs. gate resistor R_G

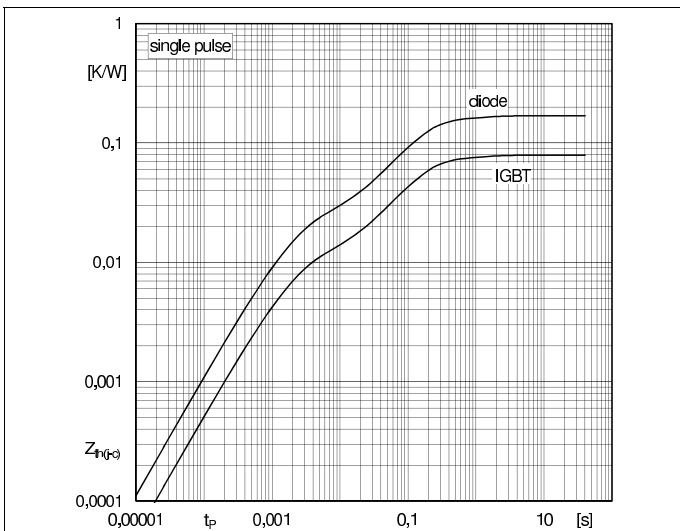


Fig. 9: Typ. transient thermal impedance

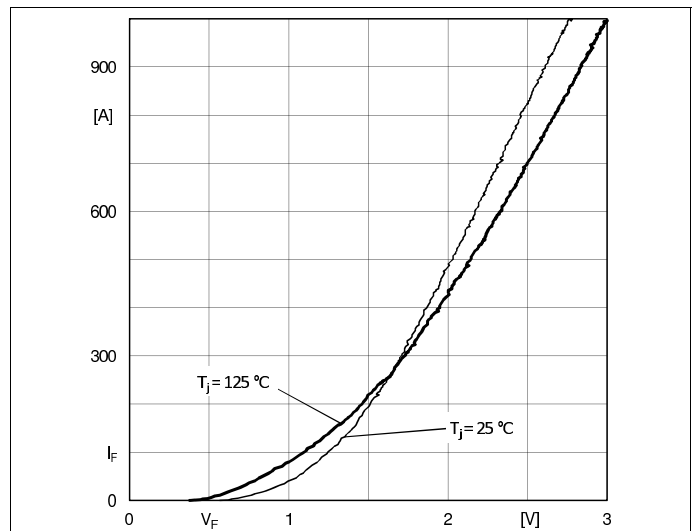


Fig. 10: Typ. CAL diode forward charact., incl. R_{CC+EE}

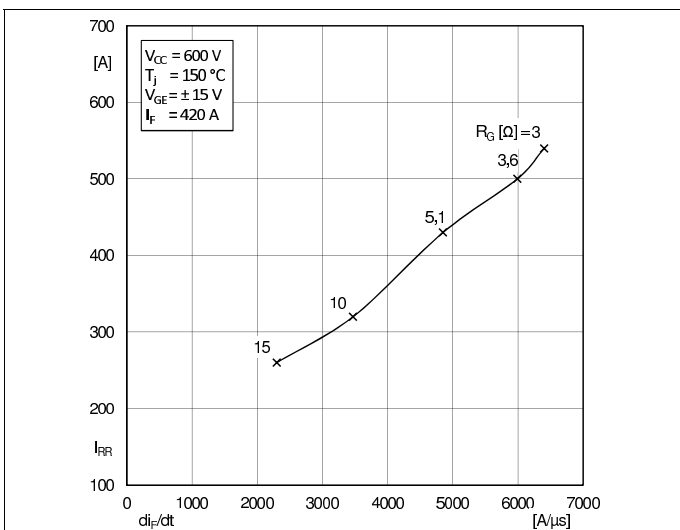


Fig. 11: Typ. CAL diode peak reverse recovery current

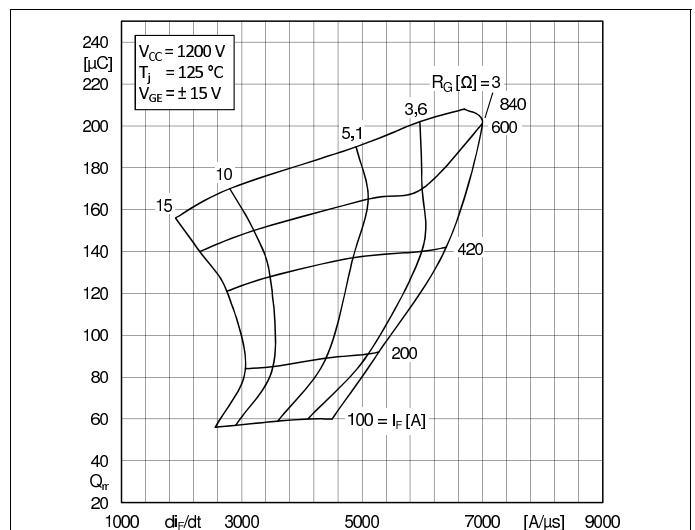
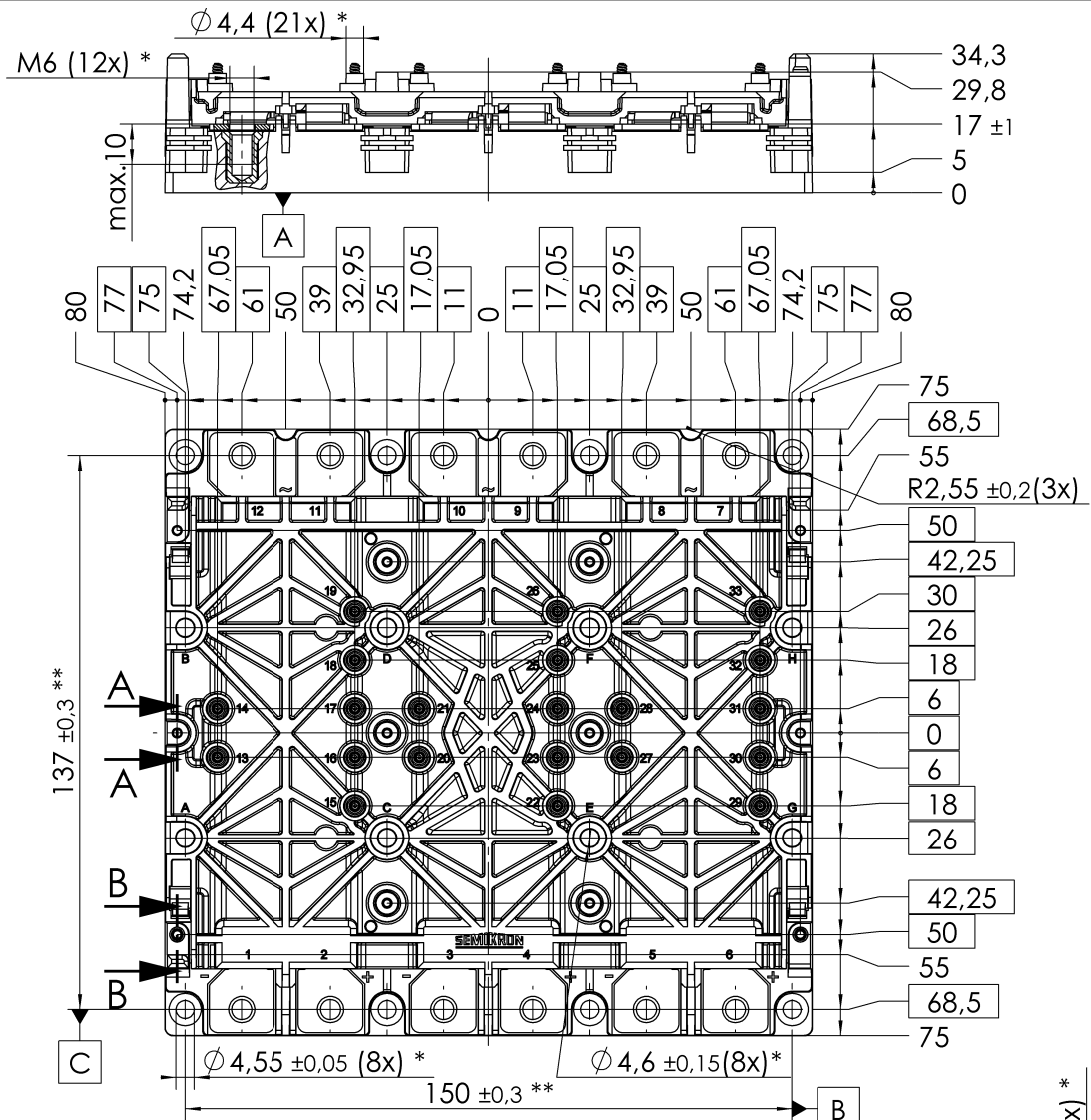


Fig. 12: Typ. CAL diode recovery charge

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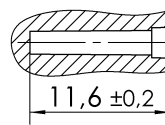
* all pos. dimensions valid when mounted

⊕ Ø 0,9 A B C

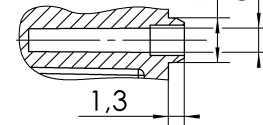
** valid for the outer 4 inserts

General Tolerances DIN ISO 2768-m
PCB spring landing pad = Ø 3,5 ± 0,2

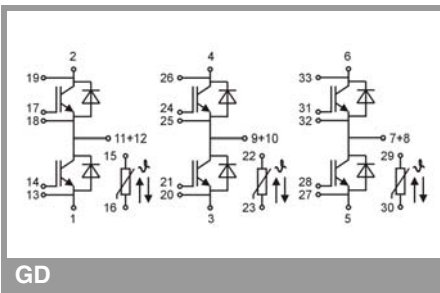
A-A (2:1)
(12x screw hole)



B-B (2:1)
(2x guide ring)



SKIM 93



GD

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.